# Pattern Classification using Belief Functions

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#### **Outline**

- Pattern classification
  - Definitions, applications
  - classical approaches, limitations
- 2. Learning evidential classifiers from data
  - Model-based approach
  - Case-based approach
  - Belief decision trees
- 3. Combination of unreliable sensors/experts
- 4. Conclusions



#### Pattern classification

- Classification = assignment of objects to predefined categories (classes)
- Applications:
  - character, speech recognition
  - diagnosis, fault identification, condition monitoring
  - target identification
  - face recognition, person identification
  - text categorization, context-based image retrieval, web mining, etc.



#### **Formalization**

- Population P of objects, each object described by two variables:
  - x: vector of d attributes (features), quantitative, qualitative, mixed
  - c: class variable, qualitative, values in finite set  $\Omega = \{\omega_1, \dots, \omega_K\}$ .
- Classifier: mapping  $f:\mathbb{R}^d\to\Omega$  allowing to predict the class of any new object described by feature vector  $\mathbf{x}$
- Building a classifier from data = supervised learning.



#### Supervised Learning

Learning set:

$$\mathcal{L} = \{(\mathbf{x}_i, c_i), i = 1, \dots, n\}$$

- Usual assumptions:
  - 1.  $\mathcal{L}$  is a realization of an iid sample drawn from  $F(\mathbf{x}, c)$ ,
  - 2. Future examples will be drawn from the same distribution.
  - 3. There exists a loss function  $L: \Omega^2 \to \mathbb{R}_+$ ,  $L(\omega_k, \omega_\ell) = \text{loss incurred if one assigns to class } \omega_k$  an object belonging to class  $\omega_\ell$ .



#### The Bayes classifier

• The optimal (Bayes) classifier  $f^*: \mathbb{R}^d \to \Omega$  is defined by

$$f^*: \mathbf{x} \mapsto \omega_k$$
 such that  $R(\omega_k | \mathbf{x}) \leq R(\omega_\ell | \mathbf{x}) \quad \forall \ell \neq k$ 

with

$$R(\omega_k|\mathbf{x}) = \sum_{\ell=1}^{c} L(\omega_k, \omega_\ell) P(\omega_\ell|\mathbf{x})$$

f\* minimizes the overall risk:

$$R(f) = \int R(f(\mathbf{x})|\mathbf{x})p(\mathbf{x})d\mathbf{x}$$



#### Approximating the Bayes classifier

- Usual approach for approximating  $f^*$ : estimate the posterior probabilities  $P(\omega_k|\mathbf{x})$ .
- Different strategies
  - parametric (ML) or non parametric (k-NN, Parzen) estimation of the class-conditional densities  $p(\mathbf{x}|\omega_{\ell})$ , combination with priors  $P(\omega_{\ell})$  ( $\ell=1,\ldots,K$ )
  - direct estimation of  $P(\omega_k|\mathbf{x})$ :
    - logistic regression,
    - neural networks,
    - decision trees, etc.



### Applicability

The above framework is relevant in applications where the learning set is:

- representative of the data expected in the operating environment (proportions ≈ prior probabilities)
- 2. large enough to provide reliable estimates of the class-conditional densities
- 3. composed of precise and certain observations.

This is not always the case in real-world applications!

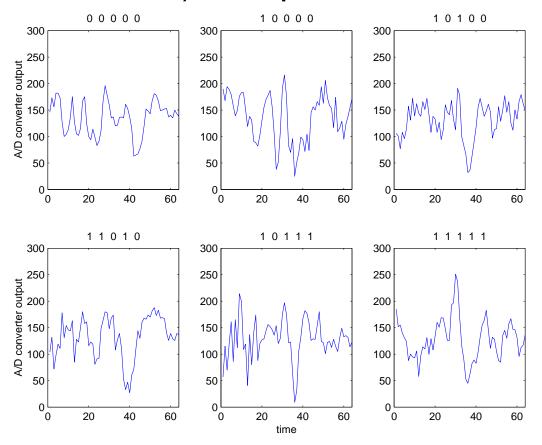


#### Analysis of sleep EEG

- Classification task: discriminate K-complexes from background activity in sleep EEG
- K-complexes = transient EEG patterns, play a major role in sleep stage assessment and diagnosis.
- Particular problems:
  - no "ground truth": data has to be subjectively labeled by a panel of experts
  - the prior probability of a K-complex occurring in a given time window is unknown (depends on the patient)



500 EEG signals encoded as 64-D patterns, 50 % negative (delta waves), 5 experts.





#### Sensor fusion

Features are obtained from s sensors

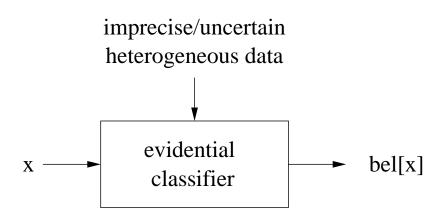
$$\mathbf{x} = (\mathbf{x}_1, \dots, \mathbf{x}_s)$$

- Some sensors may be unreliable in certain operating conditions (not all represented in the training set)
- Incomplete information, different granularity levels:
  - sensor  $S_1$ :  $n_1$  training patterns labeled as  $\{\omega_1,\omega_2\}$  or  $\omega_3$
  - sensor  $S_2$ :  $n_2$  training patterns labeled as  $\omega_1$  or  $\omega_3$ , etc...



#### The TBM framework

- A rich and flexible framework for representing various levels of uncertainties (from total ignorance to full knowledge),
- Requires fewer assumptions and less information than Probability theory
- Application to classification problems: evidential classifier.





#### Three approaches

- 1. Model-based (GBT):
  - Smets (1978)
  - Appriou (1991)
- 2. Cased-Based:
  - Denœux (1995)
- 3. Belief decision tree:
  - Elouedi and Smets (2000),
  - Denœux and Skarstein-Bjanger (2000)



#### The model-based approach

 Based on the Generalized Bayesian Theorem (x discrete):

$$\mathsf{pl}^{\Omega}[\mathbf{x}](A) = 1 - \prod_{\omega_k \in A} (1 - \mathsf{pl}^X[\omega_k](\mathbf{x})) \quad \forall A \subseteq \Omega$$

- Problems:
  - How to determine  $\operatorname{pl}^X[\omega_k]$  ?
  - Extension to continuous x



## **Determination of p** $^{X}[\omega_{k}]$

- Let  $\mathcal{L}_k$  be a learning set of  $n_k$  patterns of class  $\omega_k$ .
- Assuming  $\mathcal{L}_k$  to an iid sample from  $p(\mathbf{x}|\omega_k)$ , this conditional distribution can be estimated:  $\widehat{p}(\mathbf{x}|\omega_k)$ .
- $\operatorname{pl}^X[\omega_k]$  can then be defined by discounting the estimated probability function  $\widehat{p}(\mathbf{x}|\omega_k)$ :

$$\mathsf{pl}^X[\omega_k](\mathbf{x}) = 1 - \alpha_k + \alpha_k \widehat{p}(\mathbf{x}|\omega_k)$$

We then have

$$\mathsf{pl}^{\Omega}[\mathbf{x}](A) = 1 - \prod_{\omega_k \in A} \alpha_k (1 - \widehat{p}(\mathbf{x}|\omega_k)) \quad \forall A \subseteq \Omega$$



#### The GBT in the continuous case

Generalization to continuous x:

$$\mathsf{pl}^{\Omega}[\mathbf{x}](A) = 1 - \prod_{\omega_k \in A} \alpha_k (1 - \rho \cdot \widehat{p}(\mathbf{x}|\omega_k)) \quad \forall A \subseteq \Omega$$

with

$$\rho = (\max_{k} \sup_{\mathbf{x}} \widehat{p}(\mathbf{x}|\omega_k))^{-1}.$$

• The reliability coefficients  $\alpha_k$  can be fixed a priori or learnt from the data by minimizing an error function.



#### **Properties**

- 1. Consistency with the Bayesian approach in the case where the class-conditional distributions  $p(\mathbf{x}|\omega_k)$  and the prior probabilities  $P(\omega_k)$  are known.
- 2. Separability of hypothesis evaluation:  $m^{\Omega}[\mathbf{x}]$  can be decomposed as the conjunctive combination of K bba's  $m_k^{\Omega}[\mathbf{x}]$  defined by

$$m_k^{\Omega}[\mathbf{x}](\overline{\{\omega_k\}}) = \alpha_k (1 - \rho \cdot \widehat{p}(\mathbf{x}|\omega_k))$$

$$m_k^{\Omega}[\mathbf{x}](\Omega) = 1 - \alpha_k (1 - \rho \cdot \widehat{p}(\mathbf{x}|\omega_k))$$

3. Equivalence of aleatory and epistemic combination of observations:  $m^{\Omega}[\mathbf{x}, \mathbf{y}] = m^{\Omega}[\mathbf{x}] \odot m^{\Omega}[\mathbf{y}]$ 



### Experiment 1 (1)

- Target classification problem with two classes  $\Omega = \{\omega_1, \omega_2\}$  (e.g., aircraft and missile) and two sensors  $S_1$  and  $S_2$  (e.g. radar and infrared).
- Each sensor  $S_j$  allows to compute one feature  $x_j$ .
- Distributions of  $x_1$  and  $x_2$  in each class learnt in controlled experimental conditions:

$$p(x_1|\omega_1) = \mathcal{N}(0,1)$$
  $p(x_1|\omega_2) = \mathcal{N}(6,1)$ 

$$p(x_2|\omega_1) = \mathcal{N}(0,1)$$
  $p(x_2|\omega_2) = \mathcal{N}(2,1)$ 

• Equiprobability assumption:  $P(\omega_1) = P(\omega_2)$ .



### Experiment 1 (2)

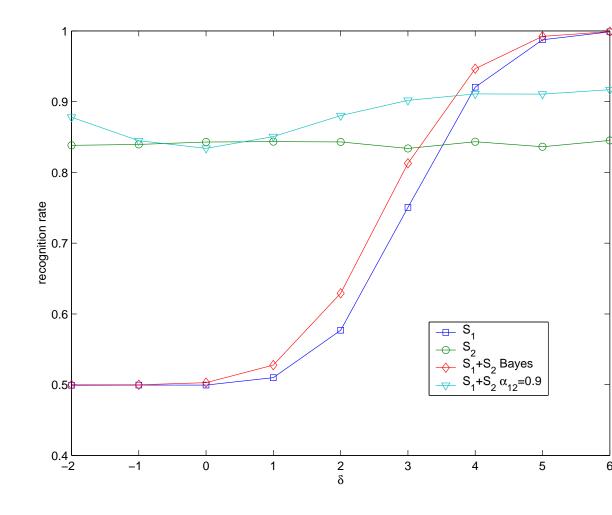
- If the distributions of  $x_1$  and  $x_2$  were the same in the operational context, the best performances would be achieved by the Bayes classifier, BUT
- it is known that the distribution of  $x_1$  for class  $\omega_2$  objects is altered due to environmental conditions.
- This is can be taken into account by discounting  $p(x_1|\omega_2)$  with rate  $1 \alpha_{1,2} > 0$ .
- $pl^{\Omega}[x_1] \odot pl^{\Omega}[x_2]$  are then computed using the GBT and combined:

$$pl^{\Omega}[x_1, x_2] = pl^{\Omega}[x_1] \bigcirc pl^{\Omega}[x_2]$$



### Experiment 1: result

$$p(x_1|\omega_2) = \mathcal{N}(\delta, 1)$$





### Experiment 2

- Two sensors  $S_1$  and  $S_2$ , three classes  $\Omega = \{\omega_1, \omega_2, \omega_3\}$ .
- We know
  - Sensor  $S_1$ :  $p(x_1|\omega_1)$ ,  $p(x_1|\omega_2)$
  - Sensor  $S_2$ :  $p(x_2|\omega_1) = p(x_2|\omega_2)$ ,  $p(x_2|\omega_3)$
- We do not know:
  - distribution of  $x_1$  in class 3:  $p(x_1|\omega_3)$
  - prior probabilities  $P(\omega_1), P(\omega_2), P(\omega_3)$
- Two solutions:
  - TBM solution
  - Bayesian solution



#### The TBM solution

- Frame for sensor  $S_1$ :  $\Omega_{12} = \{\omega_1, \omega_2\}$
- Frame for sensor  $S_2$ :  $\Omega_{\{12\}3}=\{\omega_{12},\omega_3\}$  with  $\omega_{12}=\{\omega_1,\omega_2\}$ .

$$p(x_1|\omega_1), p(x_1|\omega_2) \xrightarrow{\mathsf{GBT}} m^{\Omega_1^2}[x_1] \xrightarrow{\mathsf{vac. ext.}} m^{\Omega}[x_1] \downarrow \qquad \qquad \downarrow$$



#### The Bayesian solution

- A prior distribution on  $\Omega$  and a conditional probability density  $p(x_1|\omega_3)$  must be defined.
- Natural choice: "non-informative" priors

$$P(\omega_1) = P(\omega_2) = P(\omega_3) = 1/3$$
  
 $p(x_1|\omega_3) = \mathcal{U}_{[-1,5]}$ 

Computation of posterior probabilities:

$$P(\omega_k|x_1, x_2) = \frac{p(x_1|\omega_k)p(x_2|\omega_k)P(\omega_k)}{p(x_1, x_2)}$$

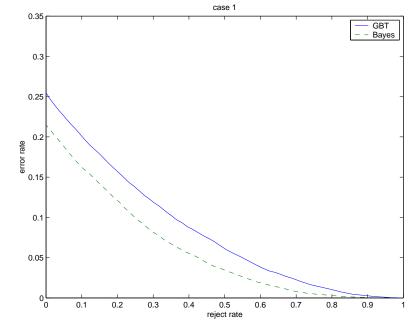


### Example 2 - Results



$$P = (1/3, 1/3, 1/3)$$

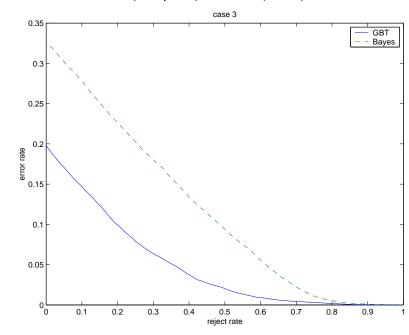
$$p(x_1|\omega_3) = \mathcal{U}_{[-1,5]}$$



#### Case 2

$$P = (0.1, 0.2, 0.7)$$

$$p(x_1|\omega_3) = \mathcal{N}(2,1)$$





#### The case-based approach

- Does not use any probabilistic model of the distribution of attributes in each class;
- Treats each example  $(\mathbf{x}_i, c_i)$  in the learning set as a piece of evidence, whose relevance depends on the dissimilarity beween the current vector  $\mathbf{x}$  and  $\mathbf{x}_i$ ;
- The *n* items of evidence are combined using the Dempster's rule of combination.
- Allows to use training data with imprecise and/or uncertain class labels (semi-supervised learning).



#### The learning set

• A more general form of the learning set:  $\mathcal{L} = \{e_i = (\mathbf{x}_i, m_i), i = 1, \dots, n\}$ 

- $m_i$ : a bba representing Your partial knowledge regarding the class of object i.
- Special cases:
  - $m(\omega_k) = 1$  : precise (standard) labelling
  - $m_i(A) = 1$  for  $A \subseteq \Omega$ : imprecise labelling
  - $m_i$  is a probability function: probabilistic labeling (opinions of N experts)
  - $m_i$  has nested focal elements: possibilistic labeling ("object i is big"), etc...



### Impact of 1 example

- The relevance of  $e_i$  as an item of evidence regarding the class of  $\mathbf{x}$  is related to the dissimilarity between the 2 vectors:
  - If  $\mathbf{x} = \mathbf{x}_i$ ,  $e_i$  is totally relevant,  $m[\mathbf{x}, e_i] \approx m_i$ .
  - If  $\mathbf{x}$  and  $\mathbf{x}_i$  are very dissimilar,  $e_i$  is irrelevant and  $m[\mathbf{x}, e_i](\Omega) = 1$ .
  - If x and  $x_i$  are somewhat disimilar,  $e_i$  is partially relevant.  $m_i$  must be discounted:

$$m[\mathbf{x}, e_i] = m_i^{\alpha(\mathbf{x}, \mathbf{x}_i)}$$

where  $\alpha(\mathbf{x}, \mathbf{x}_i) \in [0, 1]$  is a dissimilarity measure.



#### Example

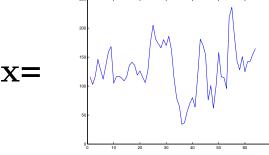
$$\Omega = \{K\text{-complex}, \delta\text{-wave}\}$$

$$\mathbf{x}_{i}$$
=

$$egin{array}{c|ccccc} A & \emptyset & \{K\} & \{\delta\} & \Omega \\ \hline m_i(A) & 0 & 0.8 & 0.2 & 0 \\ \hline \end{array}$$

$$\updownarrow \alpha(\mathbf{x}, \mathbf{x}_i) = 0.5$$

#### ↓ discounting



$$A = \emptyset \{K\} \{\delta\} \Omega$$
  
 $m[\mathbf{x}, e_i](A) = 0 \quad 0.4 \quad 0.1 \quad 0.5$ 



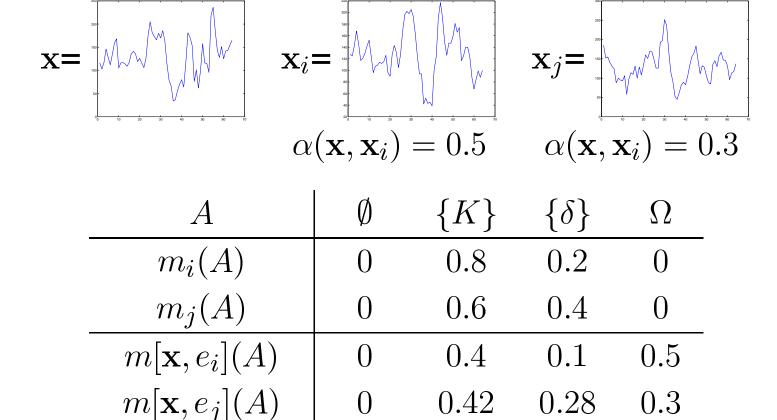
### Impact of n examples

- Each learning example induces a bba  $m[\mathbf{x}, e_i]$ .
- Assuming the n learning examples to be n distinct items of evidence, the evidence of the n examples is pooled using Dempster's rule of combination:

$$m[\mathbf{x}, \mathcal{L}] = m[\mathbf{x}, e_1] \bigcirc \ldots \bigcirc m[\mathbf{x}, e_n]$$



#### **Example**



0.196

0.282

0.372

0.15

 $m[\mathbf{x}, e_i, e_j](A)$ 



#### *Implementation*

• Dissimilarity measure defined as a function of a distance measure (e.g. Euclidean if  $\mathbf{x} \in \mathbb{R}^d$ ). For instance:

$$\alpha(\mathbf{x}, \mathbf{x}_i) = 1 - \alpha_0 \exp(-\gamma ||\mathbf{x} - \mathbf{x}_i||^2)$$

- parameters  $\alpha_0$  and  $\gamma$  can be learnt by minimization of an error function
- For faster computation:
  - use only the k nearest neighbors of x (evidential k-NN rule)
  - summarize  $\mathcal{L}$  using p prototypes (learnt in unsupervised or supervised mode)



#### Results on 'classical data'

#### Vowel data

K = 11,

d = 10

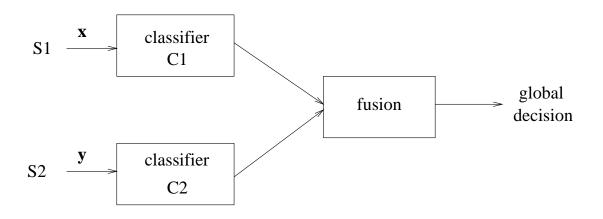
n = 568

test: 462 ex. (different speakers)

Classifier	test error rate
Multi-layer perceptron (88 hidden units)	0.49
Radial Basis Function (528 hidden units)	0.47
Gaussian node network (528 hidden units)	0.45
Nearest neighbor	0.44
Linear Discriminant Analysis	0.56
Quadratic Discriminant Analysis	0.53
CART	0.56
BRUTO	0.44
MARS (degree=2)	0.42
Case-based classifier (33 prototypes)	0.38
Case-based classifier (44 prototypes)	0.37
Case-based classifier (55 prototypes)	0.37



### Data fusion example



- K=2 classes
- $\mathbf{x} \in \mathbb{R}^5, \mathbf{y} \in \mathbb{R}^3$ , Gaussian distribution, conditionally independent
- Learning set: n = 60, cross-validation:  $n_{cv} = 100$
- test: 5000 vectors



### Data fusion: results (1)

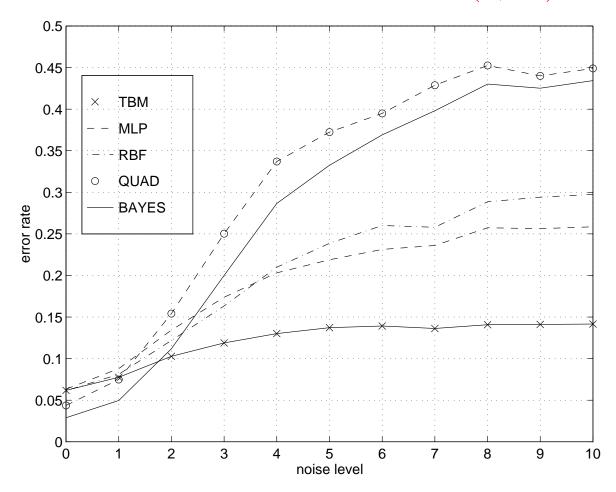
#### Test error rates: uncorrupted data

Method	x alone	y alone	${f x}$ and ${f y}$
TBM	0.106	0.148	0.061
MLP	0.113	0.142	0.063
RBF	0.133	0.159	0.083
QUAD	0.101	0.141	0.049
BAYES	0.071	0.121	0.028



### Data fusion: results (2)

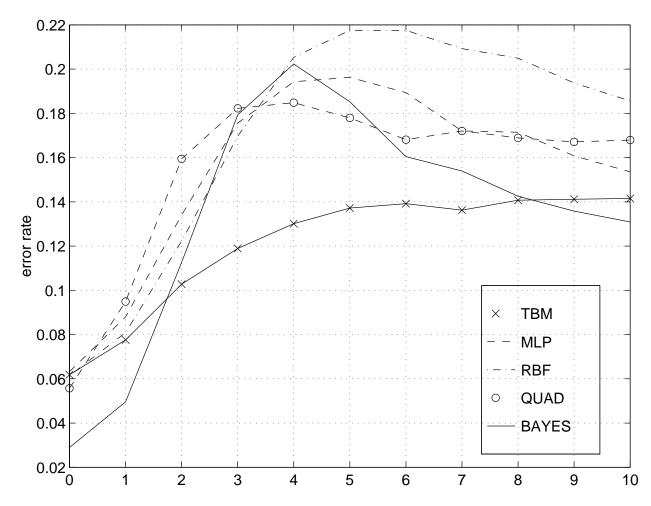
#### Test error rates: $\mathbf{x} + \epsilon$ , $\epsilon \sim \mathcal{N}(0, \sigma^2)$





### Data fusion: results (3)

### Test error rates: $\mathbf{x} + \epsilon$ , $\epsilon \sim \mathcal{N}(0, \sigma^2)$ , with rejection





#### Results on EEG data

- K = 2 classes, d = 64
- data labeled by 5 experts
- n = 200 learning patterns, 300 test patterns

$\overline{k}$	k-NN	w K-NN	TBM	TBM	
			(crisp labels)	(uncert. labels)	
9	0.30	0.30	0.31	0.27	
11	0.29	0.30	0.29	0.26	
13	0.31	0.30	0.31	0.26	



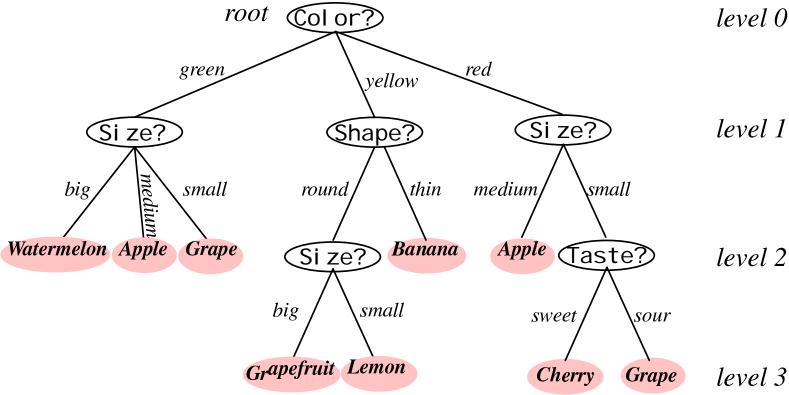
#### Belief decision trees

- Recently introduced by Elouedi and Smets (2000), Denœux and Skarstein-Bjanger (2000);
- Goals:
  - extend the DT induction methodology to learning data with imprecise or uncertain class labels
  - allow for imprecise or uncertain attribute values in the testing phase
- Several algorithms, e.g. averaging approach.



#### A decision tree

Decision tree = representation of a sequential decision procedure





#### **DT** induction

- Basic principle: recursively partition the training set using one attribute at a time.
- At each step, try to split a node (=subset of patterns) in such a way that the child nodes are, on average, 'purer' in one class than their parents.
- Classical impurity criterion:  $I(\mathcal{L}) = -\sum_{k=1}^{c} \widehat{p}_k \log_2 \widehat{p}_k$  where  $\widehat{p}_k = n_k/n$  is the proportion of class  $\omega_k$  in  $\mathcal{L}$ .
- Information gain of a categorical attribute a

$$\Delta I(a, \mathcal{L}) = I(\mathcal{L}) - \sum_{v=1}^{n_a} \frac{|\mathcal{L}_v|}{|\mathcal{L}|} I(\mathcal{L}_v)$$



## Extension to uncertain labels (1)

Interpretation of  $I(\mathcal{L})$  in the classical case:

 C=class of the case selected at random from L with equiprobability.

$$P(C = \omega_k) = \sum_{i=1}^{n} P(\text{selected case is } i) P(c_i = \omega_k)$$

$$= \frac{1}{n} \sum_{i=1}^{n} P(c_i = \omega_k) = \frac{n_k}{n}$$

•  $I(\mathcal{L})$  is the entropy of the distribution of r.v. C.



## Extension to uncertain labels (2)

- Let  $\mathcal{L} = \{(\mathbf{x}_i, m_i), i = 1, ..., n\}$ , where  $m_i$  is the bba about the class of case i.
- Select a case at as random from  $\mathcal{L}$ . For all  $A \subset \Omega$ ,

$$m(C \in A) = \sum_{i=1}^{n} P(\text{selected case is } i) m(c_i \in A)$$

$$= \frac{1}{n} \sum_{i=1}^{n} m_i(A) = \overline{m}(A)$$

• Hence,  $\overline{m}$  generalizes the empirical class distribution  $n_k/n, k=1,\ldots,K$ .



## Extension to uncertain labels (3)

 The impurity of L can be defined as the entropy of the corresponding pignistic probability distribution:

$$I(\mathcal{L}) = -\sum_{k=1}^{c} \overline{\mathsf{BetP}}(\omega_k) \log_2 \overline{\mathsf{BetP}}(\omega_k)$$

with 
$$\overline{\mathsf{BetP}} = \frac{1}{n} \sum_{i=1}^n \mathsf{BetP}_i$$

• Prepruning: discount  $\overline{m}$  with reliability factor

$$1 - \alpha = \frac{|\mathcal{L}|}{|\mathcal{L}| + \eta}$$

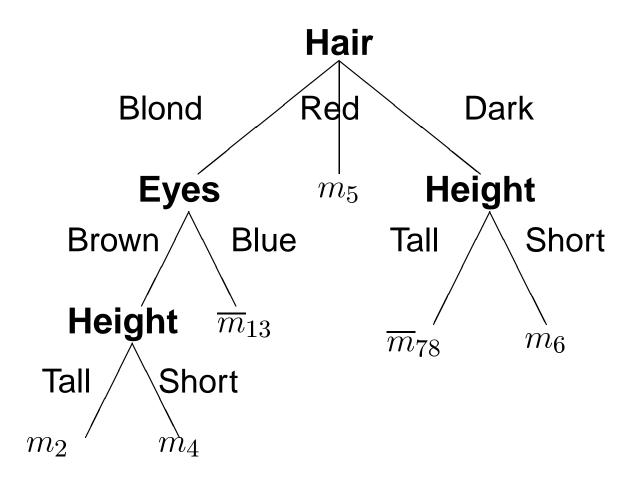


# Example: data

Hair	Eyes	Height	$m_i$			
Blond	Blue	Tall	$\omega_1, .8; \Omega, .2$			
Blond	Brown	Tall	$\omega_2, .4; \omega_1 \cup \omega_2, .4; \Omega, .2$			
Blond	Blue	Tall	$\omega_1, .9; \Omega, .1$			
Blond	Brown	Short	$\omega_2, .6; \omega_3, .2; \Omega, .2$			
Red	Blue	Tall	$\omega_2, .8; \Omega, .2$			
Dark	Brown	Short	$\omega_3, .6; \Omega, .4$			
Dark	Brown	Tall	$\omega_3, .9; \Omega, .1$			
Dark	Brown	Tall	$\omega_3, .5; \omega_1 \cup \omega_3, .2; \Omega, .3$			



## Example: tree



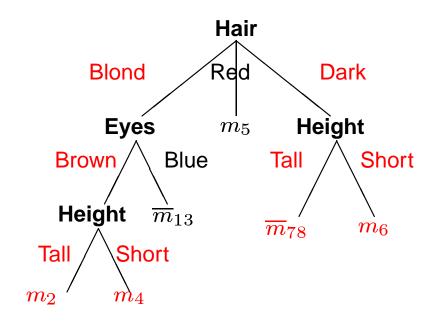


## Imprecise/uncertain attribute values

 Disjunctive case: the values of some attributes are only known to belong to subset of values.

Ex: hair ≠ red, eyes=brown height ∈ {tall, short}

$$m = m_2 \bigcirc m_4 \bigcirc \overline{m}_{78} \bigcirc m_6$$



• General case: knowledge about each attribute  $a_j$  described by a bba  $m^{a_j}$ .

## Sensor Tuning

- Pb: s sensors (experts, classifiers) express beliefs regarding the class c of an object.
- The s sensors are assumed to be distinct sources, but they may have different degrees of reliability.
- Let  $\alpha_j = P(S_j \text{ is not reliable})$ . Then a discounting rate  $\alpha_j$  should be applied to the bba  $m_{S_j}$  before combining the s sensor reports:

$$m = m_{S_1}^{\alpha_1} \bigcirc \dots \bigcirc m_{S_s}^{\alpha_s}$$

• How to learn the discounting rates  $\alpha_j$  from a set of data with known classification ?

# Learning the $\alpha_j$

- Let  $\{o_1, \ldots, o_n\}$  denote a set of n objects, with known class  $c_i$ ,  $i = 1, \ldots, n$ .
- The discounted bba provided by sensor  $S_j$  regarding the class of object  $o_i$  is  $m_{S_i}^{\alpha_j} \{o_i\}$ .
- The result of the combination for object  $o_i$  is

$$m\{o_i\} = m_{S_1}^{\alpha_1}\{o_i\} \bigcirc ... \bigcirc m_{S_s}^{\alpha_s}\{o_i\}$$



# Learning the $\alpha_j$

• The error for object  $o_i$  may be measured as:

$$\mathsf{err}_i(lpha_1,\dots,lpha_s) = \sum_{k=1}^c (\mathsf{BetP}\{o_i\}(\omega_k) - t_{ik})^2$$

where  $t_{ik} = 1$  if  $c_i = \omega_k$ , 0 otherwise.

 The optimal discounting rates may be determined by minimizing the overall error

$$(\alpha_1^*, \dots, \alpha_s^*) = \arg\min_{\alpha_1, \dots, \alpha_s} \sum_{i=1}^n \mathsf{err}_i(\alpha_1, \dots, \alpha_s)$$



## **Example**

#### $\Omega = \{Airplane, Helicopter, Rocket\}$

	Α	Н	R	$\{A,H\}$	$\{A,R\}$	$\{H,R\}$	Ω	$c_i$
$m_{S_1}\{o_1\}$	0	0	0.5	0	0	0.3	0.2	Α
$m_{S_1}\{o_2\}$	0	0.5	0.2	0	0	0	0.3	Н
$m_{S_1}\{o_3\}$	0	0.4	0	0	0.6	0	0	Α
$m_{S_1}\{o_4\}$	0	0	0	0	0.6	0.4	0	R
$m_{S_2}\{o_1\}$	0	0	0.5	0	0	0.3	0.2	Α
$m_{S_2}\{o_2\}$	0	0.5	0.2	0	0	0	0.3	Н
$m_{S_2}\{o_3\}$	0	0.4	0	0	0.6	0	0	Α
$m_{S_2}\{o_4\}$	0	0	0	0	0.6	0.4	0	R

$$\alpha_1^* = 0.28$$
  $\alpha_2^* = 0.12$ 



#### **Conclusions**

- The main approaches to pattern classification (parametric, distance-based, tree-structured classifiers) can be transposed in the TBM framework, resulting in
  - greater flexibility to handle various sources of uncertainty (e.g. imprecise or bad quality data)
  - reduced need for unjustified assumption in situations of weak available information,
  - more robust decision procedures (unreliable sensor data)
- BF- based techniques also available for related problems such as regression and clustering.